

<b>Notice of References Cited</b>	Application/Control No. 09/932,202	Applicant(s)/Patent Under Reexamination ELMAN ET AL.	
	Examiner Olisa Anwah	Art Unit 2645	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0137945	07-2004	Takagi et al.	455/558
	B	US-2002/0160751	10-2002	Sun et al.	455/412
	C	US-2003/0032447	02-2003	Bulthuis, Willem	455/556
	D	US-5,524,137	06-1996	Rhee, David R.	379/88.01
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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